

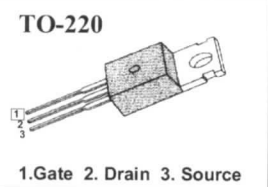
Advanced Power MOSFET

IRFZ44

FEATURES

- ◆ Avalanche Rugged Technology
- ◆ Rugged Gate Oxide Technology
- ◆ Lower Input Capacitance
- ◆ Improved Gate Charge
- ◆ Extended Safe Operating Area
- ◆ 175°C Operating Temperature
- ◆ Lower Leakage Current: 10µA (Max.) @ $V_{DS} = 60V$
- ◆ Lower $R_{DS(ON)}$: 0.020Ω (Typ.)

$BV_{DSS} = 60 V$
 $R_{DS(on)} = 0.024\Omega$
 $I_D = 50 A$



Absolute Maximum Ratings

| Symbol | Characteristic | Value | Units |
|----------------|---|--------------|-------|
| V_{DSS} | Drain-to-Source Voltage | 60 | V |
| I_D | Continuous Drain Current ($T_C=25^\circ C$) | 50 | A |
| | Continuous Drain Current ($T_C=100^\circ C$) | 35.4 | |
| I_{DM} | Drain Current-Pulsed (1) | 200 | A |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| E_{AS} | Single Pulsed Avalanche Energy (2) | 857 | mJ |
| I_{AR} | Avalanche Current (1) | 50 | A |
| E_{AR} | Repetitive Avalanche Energy (1) | 12.6 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (3) | 5.5 | V/ns |
| P_D | Total Power Dissipation ($T_C=25^\circ C$) | 126 | W |
| | Linear Derating Factor | 0.84 | |
| T_J, T_{STG} | Operating Junction and Storage Temperature Range | - 55 to +175 | °C |
| T_L | Maximum Lead Temp. for Soldering Purposes, 1/8. from case for 5-seconds | 300 | |

Thermal Resistance

| Symbol | Characteristic | Typ. | Max. | Units |
|-----------------|---------------------|------|------|-------|
| $R_{\theta JC}$ | Junction-to-Case | -- | 1.19 | °C/W |
| $R_{\theta CS}$ | Case-to-Sink | 0.5 | -- | |
| $R_{\theta JA}$ | Junction-to-Ambient | -- | 62.5 | |

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IRFZ44

N-CHANNEL POWER MOSFET

Electrical Characteristics ($T_C=25^\circ\text{C}$ unless otherwise specified)

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Test Condition |
|------------------------|---|------|-------|-------|---------------------|---|
| BV_{DSS} | Drain-Source Breakdown Voltage | 60 | -- | -- | V | $V_{GS}=0V, I_D=250\mu A$ |
| $\Delta BV/\Delta T_J$ | Breakdown Voltage Temp. Coeff. | -- | 0.063 | -- | V/ $^\circ\text{C}$ | $I_D=250\mu A$ See Fig 7 |
| $V_{GS(th)}$ | Gate Threshold Voltage | 2.0 | -- | 4.0 | V | $V_{DS}=5V, I_D=250\mu A$ |
| I_{GSS} | Gate-Source Leakage, Forward | -- | -- | 100 | nA | $V_{GS}=20V$ |
| | Gate-Source Leakage, Reverse | -- | -- | -100 | | $V_{GS}=-20V$ |
| I_{DSS} | Drain-to-Source Leakage Current | -- | -- | 10 | μA | $V_{DS}=60V$ |
| | | -- | -- | 100 | | $V_{DS}=48V, T_C=150^\circ\text{C}$ |
| $R_{DS(on)}$ | Static Drain-Source On-State Resistance | -- | -- | 0.024 | Ω | $V_{GS}=10V, I_D=25A$ (4) |
| g_{fs} | Forward Transconductance | -- | 32.6 | -- | \bar{u} | $V_{DS}=30V, I_D=25A$ (4) |
| C_{iss} | Input Capacitance | -- | 1770 | 2300 | pF | $V_{GS}=0V, V_{DS}=25V, f=1\text{MHz}$ See Fig 5 |
| C_{oss} | Output Capacitance | -- | 590 | 680 | | |
| C_{rss} | Reverse Transfer Capacitance | -- | 220 | 255 | | |
| $t_{d(on)}$ | Turn-On Delay Time | -- | 20 | 40 | ns | $V_{DD}=30V, I_D=50A,$ $R_G=9.1\Omega$ See Fig 13 (4) (5) |
| t_r | Rise Time | -- | 16 | 40 | | |
| $t_{d(off)}$ | Turn-Off Delay Time | -- | 68 | 140 | | |
| t_f | Fall Time | -- | 70 | 140 | | |
| Q_g | Total Gate Charge | -- | 64 | 83 | nC | $V_{DS}=48V, V_{GS}=10V,$ $I_D=50A$ See Fig 6 & Fig 12 (4) (5) |
| Q_{gs} | Gate-Source Charge | -- | 12.3 | -- | | |
| Q_{gd} | Gate-Drain (. Miller.) Charge | -- | 23.6 | -- | | |

Source-Drain Diode Ratings and Characteristics

| Symbol | Characteristic | Min. | Typ. | Max. | Units | Test Condition |
|----------|---------------------------|------|------|------|---------------|--|
| I_S | Continuous Source Current | -- | -- | 50 | A | Integral reverse pn-diode in the MOSFET |
| I_{SM} | Pulsed-Source Current (1) | -- | -- | 200 | | |
| V_{SD} | Diode Forward Voltage (4) | -- | -- | 1.8 | V | $T_J=25^\circ\text{C}, I_S=50A, V_{GS}=0V$ |
| t_{rr} | Reverse Recovery Time | -- | 85 | -- | ns | $T_J=25^\circ\text{C}, I_F=50A$ |
| Q_{rr} | Reverse Recovery Charge | -- | 0.24 | -- | μC | $di_F/dt=100A/\mu\text{s}$ (4) |

Notes;

- (1) Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- (2) $L=0.4\text{mH}, I_{AS}=50A, V_{DD}=25V, R_G=27\Omega,$ Starting $T_J=25^\circ\text{C}$
- (3) $I_{SD} \leq 50A, di/dt \leq 350A/\mu\text{s}, V_{DD} \leq BV_{DSS},$ Starting $T_J=25^\circ\text{C}$
- (4) Pulse Test : Pulse Width = $250\mu\text{s},$ Duty Cycle $\leq 2\%$
- (5) Essentially Independent of Operating Temperature